



**International
Standard**

ISO 32543-2

**Non-destructive testing —
Characteristics of focal spots in
industrial X-ray systems —**

**Part 2:
Edge method with hole or disk type
test objects**

*Essais non destructifs — Caractéristiques des foyers émissifs des
tubes radiogènes industriels —*

*Partie 2: Méthode par effet de bord avec dispositifs d'essai de type
à trous ou à disques*

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ISO copyright office
CP 401 • Ch. de Blandonnet 8
CH-1214 Vernier, Geneva
Phone: +41 22 749 01 11
Email: copyright@iso.org
Website: www.iso.org

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